# MOSFET – Power, N-Channel, SUPERFET<sup>®</sup> III 800 V, 360 m $\Omega$ , 13 A

# NTD360N80S3Z

### **Description**

800 V SUPERFET III MOSFET is ON Semiconductor's high performance MOSFET family offering 800 V breakdown voltage.

New 800 V SUPERFET III MOSFET which is optimized for primary switch of flyback converter, enables lower switching losses and case temperature without sacrificing EMI performance thanks to its optimized design. In addition, internal Zener Diode significantly improves ESD capability.

This new family of 800 V SUPERFET III MOSFET enables to make more efficient, compact, cooler and more robust applications because of its remarkable performance in switching power applications such as Laptop adapter, Audio, Lighting, ATX power and industrial power supplies.

### **Features**

- Typ.  $R_{DS(on)} = 300 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ. Q<sub>g</sub> = 25.3 nC)
- Low Stored Energy in Output Capacitance (Eoss = 2.72 μJ @ 400 V)
- 100% Avalanche Tested
- ESD Improved Capability with Zener Diode
- RoHS Compliant

### **Applications**

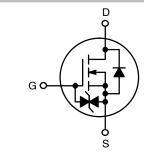
- Adapters / Chargers
- LED Lighting
- AUX Power
- Audio
- Industrial Power



### ON Semiconductor®

### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
800 V	360 m $Ω$	13 A



**POWER MOSFET** 



### **MARKING DIAGRAM**



&Z = Assembly Plant Code &3 = Data Code (Year & Week)

&K = Lo

NTD360N80S3Z = Specific Device Code

# **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

# ABSOLUTE MAXIMUM RATINGS ( $T_J = 25^{\circ}C$ , unless otherwise noted)

Symbol	Param	Value	Unit	
$V_{DSS}$	Drain-to-Source Voltage	rain-to-Source Voltage		
$V_{GS}$	Gate-to-Source Voltage	DC	±20	V
		AC (f > 1 Hz)	±30	1
I <sub>D</sub>	Drain Current	Continuous (T <sub>C</sub> = 25°C)	13	Α
		Continuous (T <sub>C</sub> = 100°C)	8.2	1
I <sub>DM</sub>	Drain Current	Pulsed (Note 1)	32.5	Α
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		40	mJ
I <sub>AS</sub>	Avalanche Current (Note 2)		2.0	А
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)		0.96	mJ
dv/dt	MOSFET dv/dt Peak Diode Recovery dv/dt (Note 3)		100	V/ns
			10	1
$P_{D}$	Power Dissipation	(T <sub>C</sub> = 25°C)	96	W
		Derate Above 25°C	0.768	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
$T_L$	Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from Case for 10 seconds)		260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 
1. Repetitive rating: pulse–width limited by maximum junction temperature. 
2.  $I_{AS} = 2.0 \text{ A}$ ,  $R_{G} = 25 \Omega$ , starting  $T_{J} = 25^{\circ}\text{C}$ . 
3.  $I_{SD} \leq 3.25 \text{ A}$ ,  $di/dt \leq 200 \text{ A}/\mu\text{s}$ ,  $V_{DD} \leq 400 \text{ V}$ , starting  $T_{J} = 25^{\circ}\text{C}$ .

# THERMAL RESISTANCE RATINGS

Symbol	Parameter	Value	Unit
$R_{ heta JC}$	Junction-to-Case - Steady State	1.3	°C/W
$R_{\theta JA}$	Junction-to-Ambient - Steady State	62.5	

# PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Marking	Package	Reel Size	Tape Width	Quantity
NTD360N80S3Z	NTD360N80S3Z	TO-252	330 mm	16 mm	2500 Units

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARACT	ERISTICS			•	•	
BV <sub>DSS</sub> Drain-to-Source Breakdown	Drain-to-Source Breakdown Voltage	$V_{GS} = 0 \text{ V, } I_D = 1 \text{ mA, } T_J = 25^{\circ}\text{C}$	800			V
		V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA, T <sub>J</sub> = 150°C	900			V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 1 mA, Referenced to 25°C		1.1		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 800 V, V <sub>GS</sub> = 0 V			1	μΑ
		V <sub>DS</sub> = 640 V, T <sub>C</sub> = 125°C		0.8		
I <sub>GSS</sub>	Gate-to-Body Leakage Current	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V			1	μΑ
ON CHARACTE	ERISTICS					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 0.3 \text{ mA}$	2.2		3.8	V
R <sub>DS(on)</sub>	Static Drain-to-Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 6.5 A		300	360	mΩ
9FS	Forward Transconductance	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 6.5 A		13.8		S
DYNAMIC CHA	RACTERISTICS			•		
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V, f = 250 kHz		1143		pF
C <sub>oss</sub>	Output Capacitance	1 -		18.1		pF
C <sub>oss(eff.)</sub>	Effective Output Capacitance	V <sub>DS</sub> = 0 V to 400 V, V <sub>GS</sub> = 0 V		236.4		pF
C <sub>oss(er.)</sub>	Energy Related Output Capacitance	V <sub>DS</sub> = 0 V to 400 V, V <sub>GS</sub> = 0 V		34		pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10 V	$V_{DS} = 400 \text{ V}, I_D = 6.5 \text{ A}, V_{GS} = 10 \text{ V}$		25.3		nC
Q <sub>gs</sub>	Gate-to-Source Gate Charge	(Note 4)		5.3		nC
$Q_{gd}$	Gate-to-Drain "Miller" Charge			8.3		nC
ESR	Equivalent Series Resistance	f = 1 MHz		4		Ω
SWITCHING CH	HARACTERISTICS					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 400 \text{ V}, I_D = 6.5 \text{ A}, V_{GS} = 10 \text{ V},$		21.2		ns
t <sub>r</sub>	Turn-On Rise Time	$R_g = 25 \Omega$ (Note 4)		18.5		ns
t <sub>d(off)</sub>	Turn-Off Delay Time			110		ns
t <sub>f</sub>	Turn-Off Fall Time			17.7		ns
SOURCE-DRAI	N DIODE CHARACTERISTICS			•		
I <sub>S</sub>	Maximum Continuous Source-to-Drain Diode Forward Current				13	Α
I <sub>SM</sub>	Maximum Pulsed Source-to-Drain Diode Forward Current				32.5	Α
V <sub>SD</sub>	Source-to-Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 6.5 A			1.2	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 3.25 A,		370		ns
Q <sub>rr</sub>	Reverse Recovery Charge	dI <sub>F</sub> /dt = 100 A/μs		3.2		μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

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<sup>4.</sup> Essentially independent of operating temperature typical characteristics.

### **TYPICAL CHARACTERISTICS**

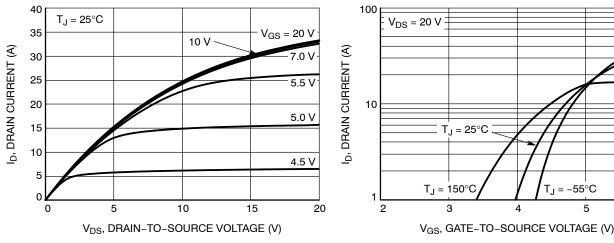


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics

6

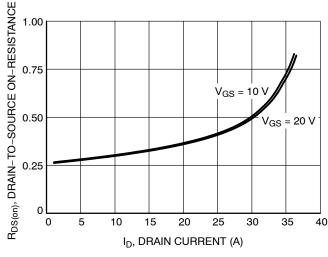


Figure 3. On Resistance vs. Drain Current

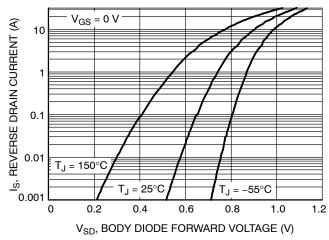


Figure 4. Diode Forward Voltage vs. Current

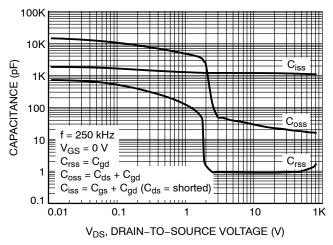


Figure 5. Capacitance Characteristics

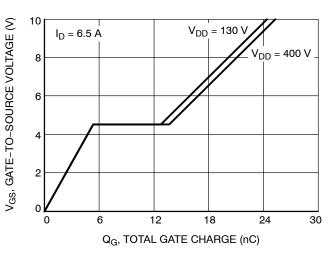


Figure 6. Gate Charge Characteristics

### **TYPICAL CHARACTERISTICS**

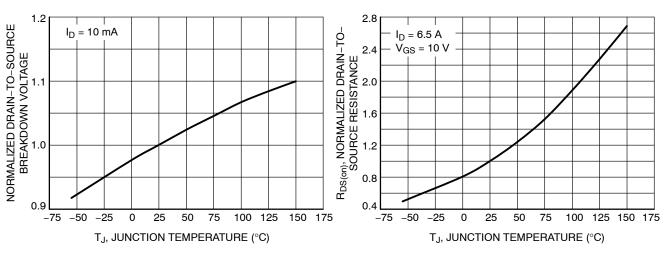
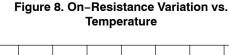


Figure 7. Normalized BV<sub>DSS</sub> vs. Temperature



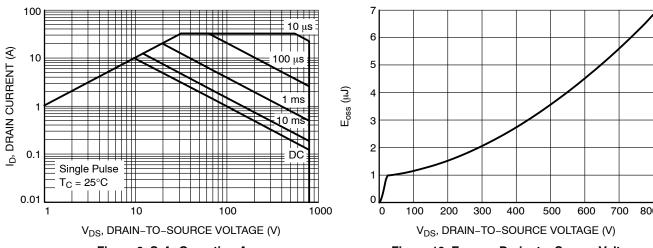


Figure 9. Safe Operating Area

Figure 10. E<sub>oss</sub> vs. Drain-to-Source Voltage

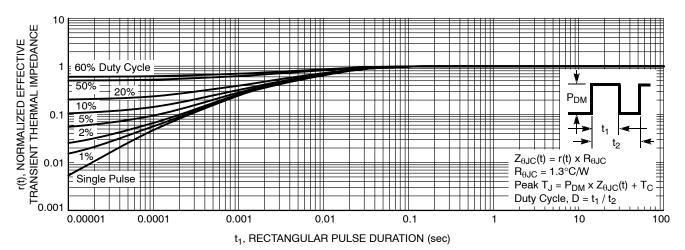


Figure 11. Transient Thermal Impedance

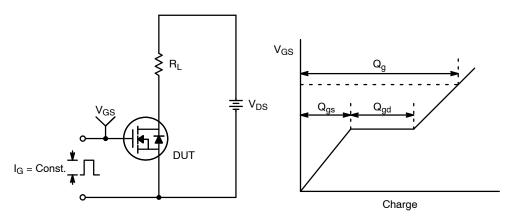


Figure 12. Gate Charge Test Circuit & Waveform

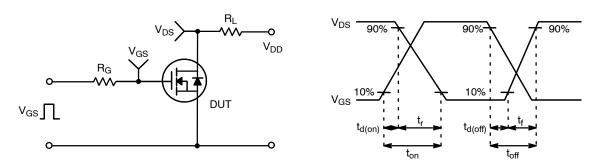


Figure 13. Resistive Switching Test Circuit & Waveforms

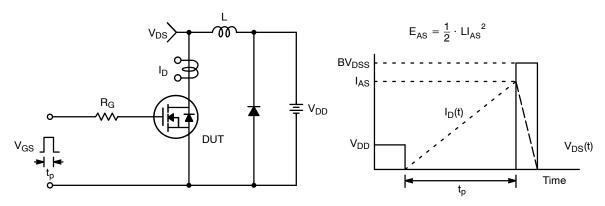


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

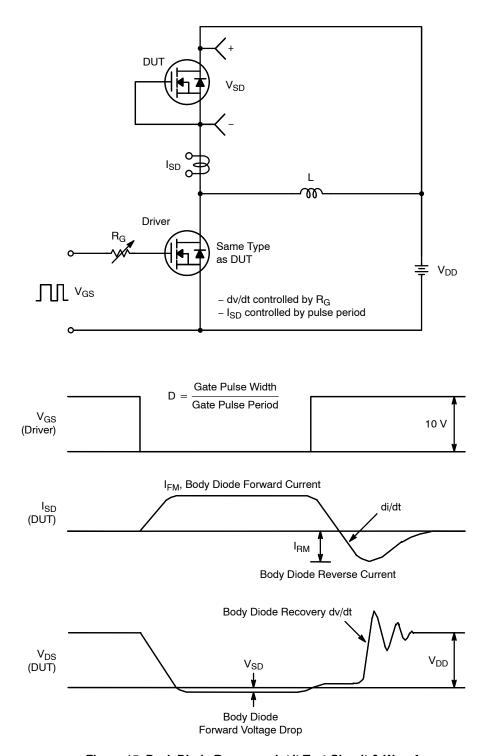


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

### CASE 369AS **ISSUE O DATE 30 SEP 2016** 6.73 6.35 5,46 5.55 MIN-6.50 MIN 6.40 0.25 MAX Ċ PLASTIC BODY STUB MIN DIODE PRODUCTS VERSION (0.59)-1.25 MIN 0.89 ⊕ 0.25 M AM C 2.29 2.28 4.56 4.57 LAND PATTERN RECOMMENDATION NON-DIODE PRODUCTS VERSION В 2.39 SEE 2.18 4.32 MIN NOTE D 0.58 0.45 5.21 MIN 10.41 9.40 SEE DETAIL A

DPAK3 (TO-252 3 LD)

NOTES: UNLESS OTHERWISE SPECIFIED

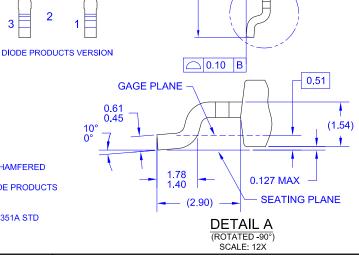
2

A) THIS PACKAGE CONFORMS TO JEDEC, TO-252,

NON-DIODE PRODUCTS VERSION

3

- ISSUE C, VARIATION AA.
  B) ALL DIMENSIONS ARE IN MILLIMETERS.
  C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
- D) SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED CORNERS OR EDGE PROTRUSION.
- E TRIMMED CENTER LEAD IS PRESENT ONLY FOR DIODE PRODUCTS
- F) DIMENSIONS ARE EXCLUSSIVE OF BURSS, MOLD FLASH AND TIE BAR EXTRUSIONS.
- G) LAND PATTERN RECOMENDATION IS BASED ON IPC7351A STD TO228P991X239-3N.



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